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Type VIII Si based Clathrates: Prospects for Giant Thermoelectric Power Factor
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ABSTRACT
Although clathrate materials are known for their small thermal conductivity, they have not shown large thermoelectric power factor so far. We present the band structures of type VIII Si, Ge, and Sn clathrates as well as the alkali and alkaline-earth intercalated type VIII Si clathrates. Our calculations revealed that this group of materials have potentially large power factor due to the existence of a large number of carrier pockets near their band edges. In particular, we calculated the charge carrier transport properties of Si₄₆⁵–VIII both for n-type and p-type materials. The exceptionally high multivalley band structure of Si₄₆⁵–VIII near the Fermi energy due to the high crystallographic symmetry resulted in giant power factor in this material. It was shown that intercalation of Si₄₆⁵–VIII with alkali and alkaline-earth guest atoms shifts the Fermi energy close to the conduction band edge and, except for Be₈Si₄₆ and Mg₈Si₄₆, they weakly influence the band structure of Si₄₆. Among these clathrate systems, Ca₈Si₄₆, Sr₈Si₄₆, and Ba₈Si₄₆ showed negative formation energy, which should facilitate their synthesis. Our results imply that the intercalation affects the conduction band of Si₄₆⁵–VIII more than its valence band. Also, interestingly, the type VIII clathrates of Si₄₆ and its derivatives (except Be₈Si₄₆ and Mg₈Si₄₆), Sn₄₆, and Ge₄₆ all have 26 carrier pockets near their valence band edge. Among different derivatives of Si₄₆⁵–VIII, Rb₈Si₄₆ and Ba₈Si₄₆ have the highest number of electron pockets near their band edges. The thermoelectric power factor was predicted using a multiband Boltzmann Transport Equation linked with parameters extracted from density functional calculations. It was shown that both the increment of charge mobility and the existence of multiple band extrema contribute in the enhancement of thermoelectric power factor considerably. Such a large power factor along with their inherently low thermal conductivity can make this group of clathrates promising thermoelectric materials.

I. INTRODUCTION
The clathrate compounds are expected to be very promising as high performance thermoelectrics not only due to their low thermal conductivity but also for their good charge carrier mobility.¹ In clathrates, the type and concentration of the guest metal atoms can be adjusted to modify their thermal and electrical properties. Moreover, the cage shape of a clathrate compound gives rise to glass-like thermal conduction due to the effective phonon scattering by rattling vibration of the guest atoms.² It is worth noting that not only the rattlers in the clathrate framework but also the open nature of the framework lead to low lattice thermal conductivity.³ Type-I and type-II clathrates based on Si, Ge and Sn elements have been studied

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extensively. The first clathrate phases of silicon type-I and type-II were synthesized over 45 years ago by extraction from alkali-metal silicides. As far as we know, only six clathrate compounds with type-VIII structure have been synthesized so far, including Eu₈Ga₁₆Ge₃₀, Ba₈Ga₁₆Ge₃₀, Sr₈Ga₁₆₋ₓAlₓGe₃₀ (6<x<10), Ba₈Ga₁₆₋ₓCuₓSn₃₀ (0<x<0.033), Sr₈Ga₁₆₋ₓAlₓSi₃₀ (8<x<10), and Sr₈GaₓSi₄₆₋ₓ. Nevertheless, none showed a large thermoelectric power factor. The following facts motivated us to systematically investigate the band structure and the thermoelectric power factor of the type-VIII Si-based clathrates. First, in our recent study we showed that the band structure of Si₄₆-VIII has an interestingly large number of closely packed electron pockets near both the conduction and valence band edges. As we know, the large density of states near the band edges leads to high thermoelectric power factor (>0.004 Wm⁻¹K⁻²). The parental Si₄₆-VIII is a good starting material to engineer Si-based clathrate thermoelectric materials. The choice of rattling atoms or the cage substitutions can adjust the transport properties of clathrates. Second, the p-type type-VIII clathrates generally show higher Seebeck coefficient than that of type-I structures while having moderate electrical conductivity. Third, the type-VIII clathrates have carriers with smaller effective masses and higher mobilities compared to those of type-I clathrates. Therefore, considering the usually low thermal conductivity of clathrates, the type-VIII clathrates are expected to result in a high ZT. Kishimoto et al have also shown experimentally that Sr₈AlₓGa₆₋ₓSi₃₀ type-VIII clathrates have higher mobility than type-I (24 cm²V⁻¹s⁻¹ at 300K compared to 5 cm²V⁻¹s⁻¹). Similar enhancements of mobility in type-VIII clathrates compared to type-I systems have been reported for Eu₈Ga₁₆₀Ge₃₀ and Eu₈Ga₃₀Ge₄₆₋ₓ. Moreover, the optimally p-type doped Eu₈Ga₁₆₆Ge₃₀-VIII clathrate was predicted to have ZT≈ 1.2 at 400K. These findings suggested that the type-VIII silicon based clathrates may have better charge transport performance than their type-I counterparts.

Our goal in the present study was to find if the electronic structures of type-VIII Si-based clathrates are appropriate for thermoelectric purposes. We try to provide a systematic insight into the charge transport properties of type-VIII Si-based clathrates. We studied the charge transport properties of this clathrate system in more details as it seems the most promising material among the considered materials in this work. To the best of our knowledge, none of the materials studied in this work have been synthesized yet and no computational study has been reported for their charge transport properties. However, the electronic structure, elastic, vibrational and thermodynamic properties of Si₄₆-VIII have been discussed in our previous study. The efficiency of a thermoelectric device relies on average temperature difference and the thermoelectric Figure-of-merit \( ZT = S^2\sigma/kT \) where \( S, \sigma, T, \) and \( k \) are thermopower, electrical conductivity, temperature, and lattice thermal conductivity, respectively. The material parameters appearing in the Figure-of-merit ZT, such as thermopower and electrical conductivity, are coupled to the electronic structure of the material and cannot be optimized independently. Materials with multivalley band structures can be potentially better thermoelectrics as all the band extrema which are close to the Fermi energy contribute to the enhancement of the power factor.

We modeled the role of each band extremum in order to gain insights into the possible enhancement of Figure-of-merit ZT by optimization of carrier concentration for such clathrate materials. We apply a two-band semi-empirical model which considers the characteristics of charge carriers and acoustic phonons. The main inputs of the model are the band structure parameters, doping concentration and the range of temperature. The rest of physical parameters are given in Table 1.
The applied multi-band model would be highly useful for engineering applications due to its simplicity. Moreover, the presented model can explain the electrical properties of clathrate Si\textsubscript{46}-VIII and give a qualitatively reliable conclusion. The results would be beneficial for the analysis of future experimental data and can be utilized to design optimized thermoelectric materials. This study also describes a predictive and quantitative theoretical calculation of the energy band structure of type-VIII Si clathrates intercalated with alkali and alkaline-earth metals. In the following section, the main input parameters of our model are described. Section III gives the details of the scattering mechanisms of the charge carriers. Computational methodology is introduced in the section IV and the calculated results along with discussions are presented in section V. The conclusions are given in section VI.

**III. COMPUTATION METHODOLOGY**

A first-principles density functional plane wave method was applied for the calculation of energy band structures.\footnote{We employed the generalized gradient approximation (GGA) within the framework of density functional theory (DFT). To approximate the electron exchange-correlation energy, the Perdew-Burke-Ernzerhof functional was utilized.} We did not include the spin-orbit coupling due to its negligible effect on thermoelectric properties of light materials.\footnote{The effect of core and semicore electrons was approximated by using ultrasoft pseudopotentials. We did not include the spin-orbit coupling due to its negligible effect on thermoelectric properties of light materials.} The energy cutoff for the plane wave basis was set to 400eV and the Brillouin zone integration calculations were carried out over a 4×4×4 Monkhorst-Pack k-point grid for all structures. The total energy convergence was set to remain better than 10\textsuperscript{-6} eV. Only a single unit cell was employed in the calculations since the clathrate unit cell is large (46 atoms for pristine structures and 54 atoms for binary clathrates). We fully relaxed the geometry of all clathrate structures. The electronic band structures were evaluated using the results of the structural relaxation calculations.

The main input parameters used in the model can be categorized into two sets. The entire first set of main parameters, such as the band structure and the lattice properties parameters (unshaded area in Table I) was derived from the density functional theory calculations of electronic structure as well as the elastic and the vibrational properties of clathrate Si\textsubscript{46}-VIII, which were reported elsewhere.\footnote{The values of the second set of the parameters (shaded area in Table I) were estimated from their typical values for silicon based semiconductors. It should be noted that the three numbers in parentheses presented in Table I are the principal effective masses (m\textsubscript{1}, m\textsubscript{2}, m\textsubscript{3})×me in which me is the effective mass of the free electron. It is interesting to note that in Si\textsubscript{46}-VIII clathrate holes have lighter effective mass than electrons. There are also more number of valley close to the band edges in the valence band compared to the conduction band. As we will discuss, these two characteristics will result in significantly higher thermoelectric power factor in p-type compared to n-type. We ignored the energy gap change with temperature in the calculations. The non-parabolicity parameters were calculated using a dense 8×8×8 mesh around each selected k-point. We included the non-isotropic nature of the effective mass using mass tensors for each valley in the calculations.} The static and high frequency dielectric constants have been computed for Si\textsubscript{46}-VIII using a linear response technique through density functional perturbation theory in VASP code as implanted in MedeA, which is described in the supporting information.\footnote{We performed calculations versus doping concentration and temperature to find the optimal values. The model accounts for two bands (one valence band and one conduction band) in order to account for the full range of carrier concentration encountered in typical thermoelectric applications.}
to determine the charge transport properties of clathrate Si$_{46}$-VIII over a wide range of doping concentration and temperature.

Table I: Si$_{46}$-VIII physical parameters used in the model.

<table>
<thead>
<tr>
<th>Parameter</th>
<th>Value</th>
</tr>
</thead>
<tbody>
<tr>
<td>Debye temperature (K)</td>
<td>549</td>
</tr>
<tr>
<td>Static dielectric constant</td>
<td>12.14</td>
</tr>
<tr>
<td>High frequency dielectric constant</td>
<td>12.05</td>
</tr>
<tr>
<td>Sound velocity (m/s)</td>
<td>5196</td>
</tr>
<tr>
<td>Lattice constant (Å)</td>
<td>10.1</td>
</tr>
<tr>
<td>Mass density (kg/m$^3$)</td>
<td>2.082×10$^3$</td>
</tr>
<tr>
<td>Energy gap (eV)</td>
<td>1.24</td>
</tr>
<tr>
<td>Conduction band (CB) effective mass- ΓH line</td>
<td>(0.89 0.89 0.49)</td>
</tr>
<tr>
<td>Conduction band (CB) effective mass- HN line</td>
<td>(0.7 0.7 0.55)</td>
</tr>
<tr>
<td>Conduction band (CB) effective mass- Γ point</td>
<td>(0.315 0.315 0.315)</td>
</tr>
<tr>
<td>Valence band (VB) effective mass- ΓH line</td>
<td>(0.75 0.56 0.56)</td>
</tr>
<tr>
<td>Valence band (VB) effective mass- HN line</td>
<td>(1.58 0.52 0.52)</td>
</tr>
<tr>
<td>Valence band (VB) effective mass- N point</td>
<td>(2.29 0.29 0.29)</td>
</tr>
<tr>
<td>Valence band (VB) effective mass- P point</td>
<td>(0.76 0.76 0.76)</td>
</tr>
<tr>
<td>Valence band (VB) effective mass- Γ point</td>
<td>(0.45 0.45 0.45)</td>
</tr>
<tr>
<td>CB acoustic phonon deformation potential (eV)</td>
<td>10</td>
</tr>
<tr>
<td>VB acoustic phonon deformation potential (eV)</td>
<td>10</td>
</tr>
</tbody>
</table>

IV. MODELING PROCESSES
The first step in the calculation procedure is solving the charge conservation condition to find the Fermi level versus temperature and doping concentration. In the second step, scattering rates for charge carriers as described in supporting information were computed. The dominant scattering mechanisms in crystalline Si$_{46}$-VIII are due to the acoustic phonons and ionized impurities. The relaxation times were calculated for acoustic phonon and ionized impurity scattering mechanisms and were combined using the well-known Matthiessen’s rule to calculate the thermoelectric properties of clathrate Si$_{46}$-VIII. The main TE properties such as the charge carrier mobility, Seebeck coefficient, and electrical conductivity were calculated by solving the multi-band multi-valley Boltzmann transport equation. The main thermoelectric properties such as electrical conductivity, Seebeck coefficient, and electronic thermal conductivity can be calculated as explained in the supporting information. Finally, we calculated the Lorentz number versus temperature. The energy gap was calculated by DFT-GGA method as aforementioned.

V. RESULTS AND DISCUSSION
Electronic band structure of alkali and alkaline-earth intercalated type-VIII Si$_{46}$ clathrates
The type-VIII clathrates have the space group I-43m (No. 217). The unit cell of Sr$_8$Si$_{46}$ is shown in Figure 1-(a). In Sr$_8$Si$_{46}$, Sr atoms are encapsulated in cages consisting of 23 atoms of Si. The framework atoms occupy four Wyckoff sites, 2a, 12d, 8c, and 24g and the Sr guest atoms (indicated by Sr in the figure) occupy the 8c Wyckoff positions. Figure 1-(b) presents 6 pockets
along the ΓH line inside the Brillouin zone and 24 half-pockets along the NH line (green), one pocket at the Γ=(0, 0, 0) point, 8 quarter-pockets at P=(1/4, 1/4, 1/4) points and 12 half-pockets at N=(1/2, 0, 0) points. Therefore, the degeneracies of peaks in the valence band and at the Γ, N, and P points and along the ΓH and NH lines are 1, 6, 2, 6, and 12, respectively, which add up to 27. The curvatures of effective mass ellipsoids as shown in the figure do not present the real values.

Figure 1: (a) Sr₈Si₄₆ as a typical crystal structure of guest-containing type-VIII clathrates. The framework atoms occupy 2a, 12d, 8c, and 24g sites and the guest atoms occupy 8c sites. (b) Brillouin zone of the Si₄₆-VIII clathrate. The hole pockets are shown at Γ=(0, 0, 0) point (brown), on the NH line (green), at P=(1/4, 1/4, 1/4) point (blue), on the ΓH line (violet), and at N=(1/2, 0, 0) points (red). The degeneracy of Γ, N, P, ΓH and NH is 1, 6, 2, 6, and 12, respectively.

In clathrate compounds an alkali intercalated atom supplies an electron to the lattice. On the other hand, aliovalent substitutions accept electrons and can compensate the donated electron by the guest atom. The discussion is extendible to alkaline-earth metal intercalated clathrate compounds as well. An alkaline-earth metal supplies two electrons when it is encapsulated in the Si framework. However, two group III atoms substituted in the Si framework can compensate for those two electrons. In order to obtain a desired carrier concentration, the number of supplied and compensated electrons determined by the guest and the substitutional atoms, respectively, should be adjusted appropriately. Therefore, one can reach the optimum carrier concentration in Clathrates through both mechanisms of intercalation and substitution. Both intercalation and substitution result in shifting the position of the Fermi level. As long as the Fermi level is not located more than 0.1 eV into the band edge, the shift can be explained by rigid band approximation. According to the rigid band approximation, as the guest atom is intercalated in the Si framework, the Fermi level is shifted upward near the conduction band edge. Moreover, if some Si sites in this intercalated Si framework are substituted by group III atoms, a downward shift of the Fermi level is expected. Such a Fermi level shift has been observed in some theoretical studies of type-VIII and type-I Si clathrates. It is interesting to know that in theoretically investigated Si clathrates, the formation energy of the ones which are simultaneously intercalated and substitutionally co-doped is lower than that of each individually doped clathrates. This property can be attributed to the strong bonding between donors and acceptors. The calculated electronic band structures of alkali (Li, Na, K, Rb, Cs) and alkaline-earth (Be, Mg, Ca, Sr, Ba) intercalated structures along with that of elemental
type-VIII clathrates such as Si\textsubscript{46}, Ge\textsubscript{46}, and Sn\textsubscript{46} have been presented in Figure 2. The horizontal dotted lines show the Fermi energy and vertical dashed lines are corresponding to Γ, H, N, P, and Γ points, respectively, in k-space. As it is evident from Figure 2, all the calculated band structures, except Be\textsubscript{8}Si\textsubscript{46} and Mg\textsubscript{8}Si\textsubscript{46} compounds, are qualitatively similar. The indirect band gaps of Ge\textsubscript{46} and Sn\textsubscript{46} are smaller than that of Si\textsubscript{46} and are equal to 0.83 and 0.44 eV, respectively. The guest atoms shift the Fermi energy into the conduction band and, except for the two cases of Be\textsubscript{8}Si\textsubscript{46} and Mg\textsubscript{8}Si\textsubscript{46}, weakly influence the band structure. It is interesting to know that Be and Mg are the only two materials in group II that have different crystal structure than other alkali and alkaline-earth metals. While all metals in group I and II have cubic structure, Be and Mg have hexagonal structures. Our calculations show that among the selected Si\textsubscript{46}–VIII clathrates, the Fermi energy of only the pristine Si\textsubscript{46}–VIII is highly degenerate p type material. Interestingly, the Fermi energy of all the intercalated Si\textsubscript{46}–VIII clathrates is deep inside the conduction band. Therefore, it is possible to adjust the Fermi energy anywhere in the gap by adjusting the number of the guest atoms in a partially filled clathrate structure. Moreover, the intercalated Si\textsubscript{46}–VIII clathrates are expected to have smaller thermal conductivity due to the guest rattling, and should result in higher figure-of-merit than the pristine Si\textsubscript{46}–VIII. We calculated the electronic formation energy for the Si based type-VIII clathrates of interest from the following equations:

\[
\Delta H_{el}(\text{Si,Ge,Sn}_{46}) = E_{\text{Si,Ge,Sn}_{46}} - 46E_{\text{Si,Ge,Sn}_{46}}
\]

\[
\Delta H_{el}(\text{A}_{8}\text{Si}_{46}) = E_{\text{A}_{8}\text{Si}_{46}} - 8E_{\text{A}} - 46E_{\text{Si}}.
\]

The first equation is for the pristine clathrate and the second equation is for the binary one, in which A refers to the selected alkali and alkaline-earth elements. The reported values are the electronic energy of formation calculated with respect to the standard state of the element. A negative value indicates that material formation is energetically favorable compared with the standard state of its components. Therefore, negative energy indicates the ease of material synthesis although materials with positive formation energy may also be synthesized with supplying extra energy to the system to initiate the reaction. The positive value indicates endothermic reaction in which the compound material is not more stable than the standard state of its components.

Figure 2 shows the existence of a large number of valence band (VB) peaks and conduction band (CB) valleys near the band edges of Si\textsubscript{46}–VIII. The number of carrier pockets near the VB edge is especially very large. This number for Si\textsubscript{46}–VIII is 26, which is much higher than the best known thermoelectric materials such as (Bi,Sb)\textsubscript{2}T\textsubscript{3} based alloys, i.e. equal to 18, or p-type Si\textsubscript{0.8}Ge\textsubscript{0.2} alloy, i.e. equal to 6. Here, we assume that the valleys (or peaks) with k\textsubscript{B}T<100 meV away from the band edge can contribute in transport. This number for the CB of Si\textsubscript{46}–VIII is 19, which is again the largest value among all the known good thermoelectric materials.

According to the result of Figure 2, the intercalation affects the conduction band of Si\textsubscript{46}–VIII more than its valence band. The intercalation with Li and Na shifts the Γ point in the conduction band (CB) upwards. This reduces the electron pockets from 19 to 18 in these materials. However, the intercalation with K, Rb, and Cs moves the Γ point in the CB down towards the mid gap. For these three alkali atoms, the higher the atomic number, the higher the shift of the Γ point. For the case of intercalation with K and Cs, the Γ point approaches the minimum of the CB and the number of carrier pockets increases to 19. However, in Cs\textsubscript{8}Si\textsubscript{46}–VIII the downward shift is so significant that the Γ point becomes the CB minimum and the number of carrier pockets reduces to 1. Therefore, Cs\textsubscript{8}Si\textsubscript{46}–VIII is not expected to have a high n-type power factor.
Among all alkali and alkali earth atoms, intercalations with Be and Mg are exceptions as they result in totally different bandstructure than that of Si$_{46}$-VIII. It is also interesting to note that Be and Mg have hexagonal crystal structure, which is different from all other alkali and alkali earth materials which have cubic structure. The intercalation with the other alkali earth atoms (Ca, Sr, Ba) will not affect the bandstructure noticeably although similar shift in $\Gamma$ point is observed. Similar to the case of alkali intercalation, as the atomic mass of the intercalated atom increases, the shift of the $\Gamma$ point towards the mid gap increases. Among these compounds, Ba$_8$Si$_{46}$-VIII shows a higher alignment of the $\Gamma$ point with other valleys at the CB edge. It should be noted that even though the degeneracy of $\Gamma$ point is 1, it has a smaller effective mass that can enhance the electron mobility.

Comparing the bandstructure of Sn$_{46}$-VIII and Ge$_{46}$-VIII with that of Si$_{46}$-VIII, we note that they both have smaller band gap and largely reduced number of carrier pockets in the CB, i.e. 2. The main reason for such a large reduction in the number of electron carrier pockets seems to be due to the convergence of the two valleys at $\Gamma H$ and NH lines in Si$_{46}$-VIII forming a single valley at H point. The two valleys in $\Gamma H$ and NH lines have large degeneracies of 6 and 12, respectively. They are seen in all the Si$_{46}$-VIII based clathrates indicating that they originate from the atomic structure of Si.

Comparing the valence bands of Sn$_{46}$-VIII, Ge$_{46}$-VIII, and Si$_{46}$-VIII (and its derivatives), we note that they all have similar structure. They all have indirect band gaps and have 26 hole pockets near their VB edge.
Figure 2: Electronic band structures for intercalated Si$_8$-VIII with alkali and alkaline earth metals and pristine type-VIII clathrates Si$_{46}$, Ge$_{46}$, and Sn$_{46}$. The first and second columns represent alkali and alkaline-earth intercalated systems respectively. The third column of Figures shows the pristine type-VIII clathrates. Each Figure displays the energy bands along several symmetry directions of the first Brillouin zone. In units of $2\pi/a$, the labeled k points correspond to $\Gamma=(0, 0, 0)$, $H=(1/2, 1/2, 1/2)$, $N=(1/2, 0, 0)$ and $P=(1/4, 1/4, 1/4)$. The Fermi level is set to 0 eV and is shown by horizontal dotted line. For all Figures, the Y axis presents energy in eV and X axis indicates the selected high symmetry path in Brillouin zone which is $\Gamma$-H-N-P-$\Gamma$. 

<table>
<thead>
<tr>
<th></th>
<th>$E_g$ (eV)</th>
<th>$N_{VB}$</th>
<th>$N_{CB}$</th>
</tr>
</thead>
<tbody>
<tr>
<td>Li$_8$Si</td>
<td>0.68</td>
<td>26</td>
<td></td>
</tr>
<tr>
<td>Be$_8$Si</td>
<td>0.74</td>
<td>26</td>
<td></td>
</tr>
<tr>
<td>Na$_8$Si</td>
<td>1.13</td>
<td>26</td>
<td></td>
</tr>
<tr>
<td>Mg$_8$Si</td>
<td>0.55</td>
<td>26</td>
<td></td>
</tr>
<tr>
<td>K$_8$Si</td>
<td>1.26</td>
<td>26</td>
<td></td>
</tr>
<tr>
<td>Ca$_8$Si</td>
<td>0.72</td>
<td>26</td>
<td></td>
</tr>
<tr>
<td>Rb$_8$Si</td>
<td>1.18</td>
<td>26</td>
<td>1</td>
</tr>
<tr>
<td>Sr$_8$Si</td>
<td>1.0</td>
<td>26</td>
<td>2</td>
</tr>
<tr>
<td>Cs$_8$Si</td>
<td>1.24</td>
<td>26</td>
<td>19</td>
</tr>
</tbody>
</table>
The main structural and band structure parameters calculated for the studied clathrate materials are presented in Table II.

Table II: The predicted values of the lattice constants, formation energies and fundamental band gaps for the Si based type-VIII clathrates.

<table>
<thead>
<tr>
<th>Type-VIII clathrate</th>
<th>Lattice constant (Å)</th>
<th>Formation energy (kJ/mol)</th>
<th>Band gap (eV)</th>
<th>Density (g/cm³)</th>
<th>VB degeneracy</th>
<th>CB degeneracy</th>
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<tr>
<td>Si₄₆</td>
<td>10.10</td>
<td>7.9</td>
<td>1.24</td>
<td>2.082</td>
<td>26</td>
<td>19</td>
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<tr>
<td>Ge₄₆</td>
<td>10.674</td>
<td>7.349</td>
<td>0.83</td>
<td>4.561</td>
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<td>2</td>
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<td>Sn₄₆</td>
<td>12.274</td>
<td>5.920</td>
<td>0.44</td>
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<td>2</td>
</tr>
<tr>
<td>Li₈Si₄₆</td>
<td>10.1</td>
<td>159.80</td>
<td>0.68</td>
<td>2.171</td>
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<td>18</td>
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<td>Na₈Si₄₆</td>
<td>10.17</td>
<td>81.57</td>
<td>0.74</td>
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<td>18</td>
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<td>84.95</td>
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<td>19</td>
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<td>19</td>
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<tr>
<td>Mg₈Si₄₆</td>
<td>10.12</td>
<td>287.14</td>
<td>-</td>
<td>2.381</td>
<td>-</td>
<td>-</td>
</tr>
<tr>
<td>Ca₈Si₄₆</td>
<td>10.177</td>
<td>-73.41</td>
<td>0.55</td>
<td>2.54</td>
<td>26</td>
<td>18</td>
</tr>
<tr>
<td>Sr₈Si₄₆</td>
<td>10.276</td>
<td>-112.76</td>
<td>0.72</td>
<td>3.05</td>
<td>26</td>
<td>18</td>
</tr>
<tr>
<td>Ba₈Si₄₆</td>
<td>10.385</td>
<td>-97.17</td>
<td>1</td>
<td>3.7</td>
<td>26</td>
<td>19</td>
</tr>
</tbody>
</table>

It can be seen that all intercalated compounds are heavily metallic. However, for thermoelectric applications, a carrier concentration reduction is necessary. To address this issue, we studied partial intercalation of Na₈Si₄₆, as an example. The calculations showed negligible change in band structure; however, the Fermi energy changed substantially. Figure 3 shows the calculation of Fermi energy in Na₈Si₄₆ versus Na fraction. It can be seen that the Fermi energy can shift up to 1.54 eV at x=0.5 compared to pure Si₄₆ which is a p-type material. In practice, it is expected that Na amount of less than 1% will result in optimum Fermi energy for n-type material, which will be discussed in Figure 4. Since DFT is zero temperature calculation, the Fermi energy at room temperature or higher, which is of interest for TE applications, will be different than that of the zero temperature. However, the plot shows the trend of reduction of the Fermi energy as the number of Na atoms reduces.
Figure 3: Intercalation of alkali and alkaline-earth atoms makes a shift in Fermi energy of clathrate Si$_{46}$-VIII. The left panel demonstrates the shift in Fermi level due to intercalation of eight Na atoms. The right panel shows how adding the Na atoms to clathrate Si$_{46}$-VIII places Fermi energy deeper into the conduction band. The squares correspond to 0.5, 1, 4, and 8 Na atoms in the unit cell, respectively. The zero energy in this plot is the conduction band edge of Si$_{46}$-VIII.

It is also notable that, by increasing the temperature, the Fermi function is broadened; hence, the probability of occupying higher energy states is increased, which leads to a shift in the optimum Fermi energy. Figure 4 represents the thermal broadening of Fermi distribution in both n-type and p-type Si$_{46}$-VIII clathrates along with the shift of the Fermi energy towards the center of the energy gap. The width of the thermal broadening in the figure is $6k_BT$, which is for demonstration. In the numerical calculations, the energy integrals were calculated up to $20k_BT$ above the Fermi energy for higher accuracy. It is evident from Figure 4 that three conduction bands and 5 valence bands contribute to the transport.

Figure 4: Broadening of Fermi energies in both n-type and p-type Si$_{46}$-VIII clathrates. The label letters were colored with the same color of each individual band.

We will continue with focusing on the charge transport properties of Si$_{46}$-VIII from here and leave the properties of the other materials for future studies.
Comparison of major thermoelectric properties of crystalline Si$_{46}$-VIII

Figure 5 presents a comparison between the electrical conductivity and Seebeck coefficient of Si$_{46}$-VIII clathrate for both p-type and n-type materials. The primary point is that the electrical conductivity and the Seebeck coefficient have consistent behavior. The Seebeck coefficient of p-type Si$_{46}$-VIII is higher than that of n-type due to the presence of more number of valleys in valence band close to Fermi level. Interestingly, the electrical conductivity of p-type Si$_{46}$-VIII is also higher than that of n-type Si$_{46}$-VIII, which is due to the smaller effective mass of holes in this material system.

It is observed that as the temperature increases the discrepancy decreases and diminishes at 1000 °C. With the increase of the temperature, the thermal broadening increases which changes the contribution of the valleys in valence and conduction bands. As it can be seen in Figure 5-(a), the electrical conductivity decreases smoothly with temperature and does not show a bipolar conduction at high temperature, which is due to the large band gap of the material.

![Figure 5: (a) Electrical conductivity and Seebeck coefficient versus temperature and (b) power factor (PFT) for both p-type and n-type Si$_{46}$-VIII materials at doping concentration of 1.1×10$^{21}$ cm$^{-3}$.](image)

The majority carrier concentration has its maximum value at lower temperature region and does not change clearly with increasing temperature. Figure 5-(b) shows the Seebeck coefficient variation as a function of the temperature for crystalline Si$_{46}$-VIII. Consistent with the behavior of the electrical conductivity, the Seebeck coefficient increases continuously with temperature. The unchanged slope of Seebeck coefficient curve in higher temperature region can be attributed to relatively large band gap of Si$_{46}$-VIII which prevents the bipolar conduction. The bipolar effect is expected to be more pronounced in Ge$_{46}$-VIII and Sn$_{46}$-VIII clathrates due to their smaller band gaps, which would lead to reduction of high temperature thermoelectric power factor.

The carrier mean free path (MFP) versus temperature has been presented in Figure 6. Temperature increment from room temperature to 1000 °C leads to ~65-70% reduction in MFP of electrons and holes, which can be attributed to the increased scattering of the charge carriers by acoustic phonons.
Figure 6: The mean free path of majority charge carriers versus temperature for Si_{46}-VIII with optimum doping concentration of $1.1 \times 10^{21}$ cm$^{-3}$.

The predicted accumulated electrical conductivity for p-type Si$_{46}$-VIII (calculated at T=1000 $^\circ$C) has been presented in Figure 7 as a function of the wavelength. It is evident from Figure 7 that the electrons and holes have similar range of wavelength and conduction happens dominantly by the ones with wavelength of 1-3 nm and the smallest wavelength is comparable with the size of the unit cell.

Figure 7: Accumulated electrical conductivity for p-type (red) and n-type (blue) crystalline Si$_{46}$-VIII versus the carrier wavelength at 1000 $^\circ$C at $N_A=1.1 \times 10^{21}$ cm$^{-3}$. The charge carriers that contribute dominantly in conductivity have wavelength smaller than a few nanometers, which is comparable with the size of the unit cell.

The mobility behavior of Si$_{46}$-VIII

Both the electron and hole mobilities are mainly affected by ionized impurity and acoustic phonon scatterings. At low temperature, the ionized impurity scattering is dominant. At high temperature, the acoustic phonons become dominant, which explains the mobility reduction with the increase of temperature. The calculated Hall mobility versus temperature in Figure 8 clearly depicts that the amount of Hall mobility is very low for both types of charge carriers.
Lorentz Number

The total thermal conductivity of the material consists of lattice and electronic parts. In highly doped semiconductors, the contribution of charge carriers can be significant and increase the thermal conductivity. The electronic thermal conductivity can be calculated from the Lorentz number. The Lorentz number can be approximated using Wiedemann–Franz law by $L = 2.45 \times 10^{-8} \frac{W \Omega}{K^2}$. However, the approximation error can be large and quite often cannot explain the experimental data. It has been discussed that if a material has a very sharp electronic density of states near the Fermi level, the Wiedemann-Franz law is violated and the Lorentz number becomes smaller than its theoretical value. This can occur in strongly correlated materials in which the Wiedemann-Franz law is no longer valid or materials with tightly bound electronic $f$ orbitals such as YbAl$_3$. Moreover, the concept of resonant levels or tuning the doping concentration and layer thickness in superlattices can be also exploited to implement this method for reducing the Lorentz number. Our calculation of the Lorentz number of Si$_{46}$-VIII also revealed reduced Lorentz number for this material, which decreases with temperature.

Figure 8: Hall mobility versus temperature for p-type (red) and n-type (blue) Si$_{46}$-VIII.

Figure 9: Lorentz number versus temperature for p-type (red) and n-type (blue) Si$_{46}$-VIII.

Figure 9 exhibits the Lorentz number versus temperature for both p-type and n-type Si$_{46}$-VIII. For temperatures above 800 $^\circ$C, the Lorentz number increases and the calculated value at 1000...
0C amounts to \(1.82 \times 10^{-8} \, W\Omega/K^2\), which is nearly 30% smaller than the theoretical value for the parabolic energy band of free electrons, i.e. \(2.44 \times 10^{-8} \, W\Omega/K^2\).

VI. CONCLUSION

The electronic band structure of alkali and alkaline-earth intercalated type-VIII Si clathrates as well as pristine type-VIII \(\text{Si}_{46}, \text{Ge}_{46}\), and \(\text{Sn}_{46}\) clathrates were investigated by DFT-GGA. The band structure considerations indicated that all these materials, except \(\text{BeSi}_{46}-\text{VIII}\) and \(\text{MgSi}_{46}-\text{VIII}\), have favorable band structure for thermoelectric applications. In particular, our calculation of the thermoelectric properties of \(\text{Si}_{46}-\text{VIII}\) predicted a giant thermoelectric power factor. We applied a semi-classical multi-band model which utilized first principal calculated input parameters to derive the thermoelectric transport properties including the Seebeck coefficient and the electrical conductivity versus temperature. The effect of temperature and doping concentration on thermoelectric properties of \(\text{Si}_{46}-\text{VIII}\) were investigated using a multiband Boltzmann transport equation within relaxation time approximation. The effect of temperature variation on some other transport properties such as the charge carrier MFPs, Hall mobility, and Lorentz number were studied for p-type and n-type \(\text{Si}_{46}-\text{VIII}\). Our calculations showed that charge carriers with wavelengths comparable to the size of the unit cell dominantly contribute in electrical conduction. We also predicted the reduction of Lorentz number in both p-type and n-type \(\text{Si}_{46}-\text{VIII}\), which would be beneficial for enhancing ZT. Therefore, \(\text{Si}_{46}-\text{VIII}\) is a promising parent material for thermoelectric application. Among these materials, \(\text{Ca}_{8}\text{Si}_{46}\), \(\text{Sr}_{8}\text{Si}_{46}\), and \(\text{Ba}_{8}\text{Si}_{46}\) have negative formation energy, which indicates their ease of synthesis compared to the others. The intercalation with alkali and alkaline-earth atoms, except Mg and Be, weakly affects the band structure; however, can significantly reduce the thermal conductivity due to the rattling effect. Therefore, the combination of the predicted giant power factor and the reduction of the thermal conductivity should result in a large thermoelectric figure-of-merit.

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